

AON3806-VB Datasheet Dual N-Channel 20 V (D-S) MOSFET

PRODUC	DUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (TYP.)			
	0.0170 at V _{GS} = 4.5 V	20				
20	0.0240 at V _{GS} = 2.5 V	17	12 nC			
	0.0490 at V _{GS} = 1.8 V	10				

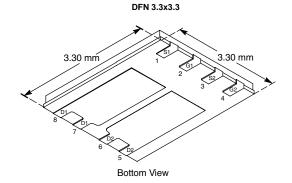
FEATURES

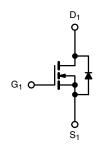
• Trench power MOSFET

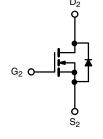
APPLICATIONS

- DC/DC
- Notebook system power
- POL









N-Channel MOSFET

N-Channel MOSFET

ABSOLUTE MAXIMUM RATING	S (T _A = 25 °C, t	ınless otherv	wise noted)		
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V _{DS}	20	V	
Gate-Source Voltage		V _{GS}	± 8	v	
	T _C = 25 °C		20		
Continuous Dunin Comment /T. 150 °C)	T _C = 70 °C	1	15.8		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	- I _D	8 a, b		
	T _A = 70 °C	1	6.5 ^{a, b}	•	
Pulsed Drain Current		I _{DM}	40	A	
Osalis as a Osalas Bais Bisala Osala	T _C = 25 °C		15		
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	2.2 ^{a, b}		
Single Pulse Avalanche Current		I _{AS}	15		
Single Pulse Avalanche Energy L = 0.1 mH		E _{AS}	11	mJ	
	T _C = 25 °C		20		
Martin and Branch Black and the	T _C = 70 °C	1 5	12.8	10/	
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{a, b}	w	
	T _A = 70 °C	1	1.6 ^{a, b}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150		
Soldering Recommendations (Peak Temperature) c, d			260	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum Junction-to-Ambient	t ≤ 10 s	R_{thJA}	38	48	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	4.3	5.4	C/VV	

Notes

- a. Package limited, T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under Steady State conditions is 110 °C/W.



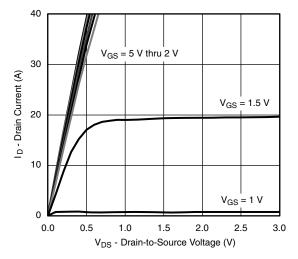
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static			•	<u>'</u>	I.	
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$		-	22	-	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-3	-	mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	0.4	-	1	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	-	-	± 100	nA
Zara Cata Valtaga Drain Current		V _{DS} = 20 V, V _{GS} = 0 V	-	-	1	μА
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V, T _J = 55 °C	-	-	10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20	-	-	Α
		V _{GS} = 4.5 V, I _D = 10 A	-	0.0170	-	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 2.5 V, I _D = 9 A	-	0.0240	-	Ω
		$V_{GS} = 1.8 \text{ V}, I_D = 8.2 \text{ A}$	-	0.0490	-	
Forward Transconductance a	9fs	V _{DS} = 10 V, I _D = 10 A	-	47	-	S
Dynamic ^b						
Input Capacitance	C _{iss}		-	1120	-	
Output Capacitance	Coss	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	180	-	pF
Reverse Transfer Capacitance	C _{rss}		-	80	-	1
· · · · · · · · · · · · · · · · · · ·	_	V _{DS} = 15 V, V _{GS} = 8 V, I _D = 10 A	-	21	32	nC
Total Gate Charge	Q_g		-	12	18	
Gate-Source Charge	Q _{qs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$	-	2	-	
Gate-Drain Charge	Q _{gd}		-	1.3	-	
Gate Resistance	R_{g}	f = 1 MHz	-	1.8	3.6	Ω
Turn-On Delay Time	t _{d(on)}		-	10	15	
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_L = 1.25 \Omega$	-	10	15	- ns
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 8 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	-	35	55	
Fall Time	t _f		-	10	15	
Turn-On Delay Time	t _{d(on)}		-	10	15	
Rise Time	t _r	V_{DD} = 10 V, R_L = 1.25 Ω	-	10	15	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 8 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$	-	25	40	
Fall Time	t _f		-	10	15	
Drain-Source Body Diode Characteristi	cs			1	ı	
Continuous Source-Drain Diode Current	Is	T _C = 25 °C	-	-	19	
Pulse Diode Forward Current	I _{SM}	-	-	-	40	A
Body Diode Voltage	V _{SD}	I _S = 8 A, V _{GS} = 0 V	-	0.81	1.2	V
Body Diode Reverse Recovery Time	t _{rr}	. 22	-	20	30	ns
Body Diode Reverse Recovery Charge	Q _{rr}		-	15	25	nC
Reverse Recovery Fall Time	ta	$I_F = 8 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	12.5	-	
Reverse Recovery Rise Time	t _b	_		7.5	_	ns

Notes

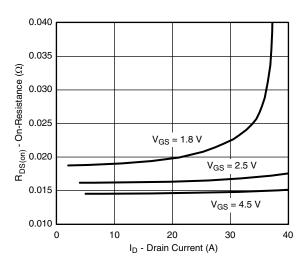
- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

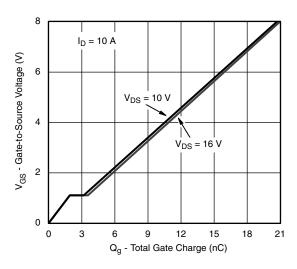




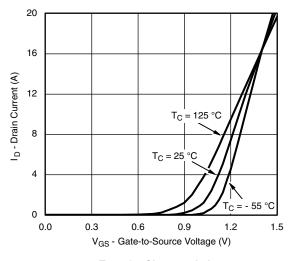
Output Characteristics



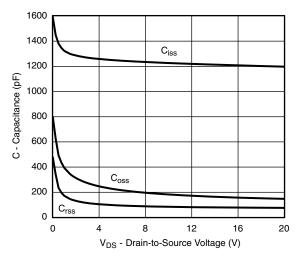
On-Resistance vs. Drain Current and Gate Voltage



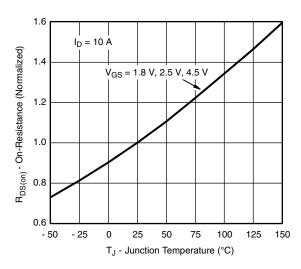
Gate Charge



Transfer Characteristics

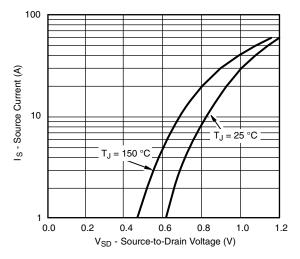


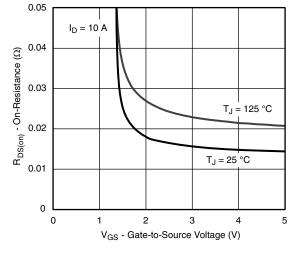
Capacitance



On-Resistance vs. Junction Temperature

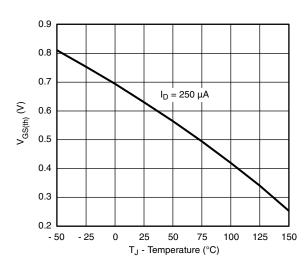


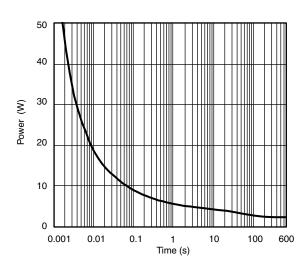




Source-Drain Diode Forward Voltage

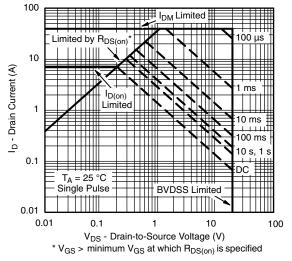






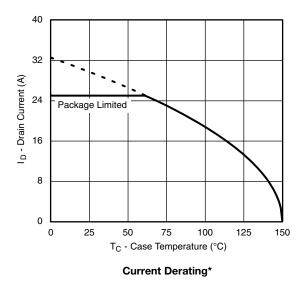
Threshold Voltage

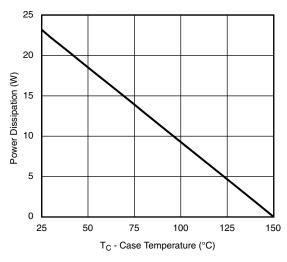
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient



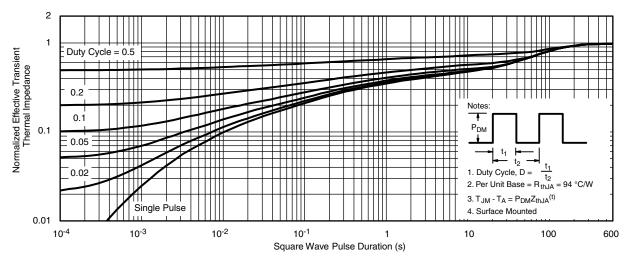




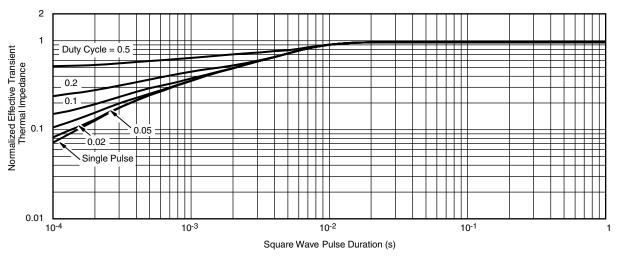
Power Derating

 $^{^*}$ The power dissipation P_D is based on T_J (max.) = 150 $^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





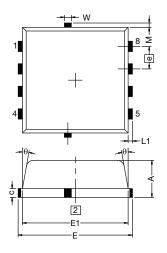
Normalized Thermal Transient Impedance, Junction-to-Ambient

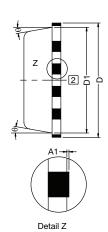


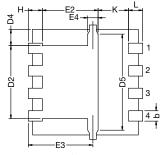
Normalized Thermal Transient Impedance, Junction-to-Case



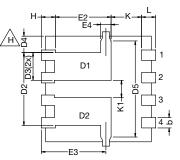
DFN3.3X3.3 (Dual)







Backside view of single pad



Backside view of dual pad

Notes
1. Inch will govern
2 Dimensions exclusive of mold gate burrs
3. Dimensions exclusive of mold flash and cutting burrs

DIM		MILLIMETERS			INCHES		
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.97	1.04	1.12	0.038	0.041	0.044	
A1	0.00	-	0.05	0.000	-	0.002	
b	0.23	0.30	0.41	0.009	0.012	0.016	
С	0.23	0.28	0.33	0.009	0.011	0.013	
D	3.20	3.30	3.40	0.126	0.130	0.134	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
D3	0.48	-	0.89	0.019	-	0.035	
D4		0.47 typ.		0.0185 typ			
D5		2.3 typ.			0.090 typ		
E	3.20	3.30	3.40	0.126	0.130	0.134	
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	1.75	1.85	1.98	0.069	0.073	0.078	
E4		0.034 typ.			0.013 typ.		
е	0.65 BSC			0.026 BSC			
K		0.86 typ.			0.034 typ.		
K1	0.35	-	-	0.014	-	-	
Н	0.30	0.41	0.51	0.012	0.016	0.020	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
θ	0°	-	12°	0°	-	12°	
W	0.15	0.25	0.36	0.006	0.010	0.014	
М	0.125 typ.				0.005 typ.		

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